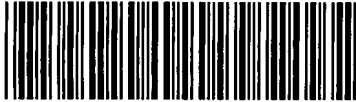


Search Notes

Application/Control No.

10/565,879

Examiner

George A. Goudreau

Applicant(s)/Patent under
Reexamination

TAKAMATSU

Art Unit

1763

SEARCHED

| Class | Subclass | Date | Examiner |
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| 216 | 88 | 4-071 | GAG |
| 216 | 89 | | GAG |
| 438 | 692 | | GAG |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
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| STN: CAPLUS, JAPIO, INSPEC, USPATFULL | 4-071 | GAG |
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